

Search Notes

Application/Control No.

10/052,447

Examiner

Sing P. Chan

Applicant(s)/Patent under
Reexamination

SHARTLE, ROBERT JUSTICE

Art Unit

1734

SEARCHED

Class	Subclass	Date	Examiner
156	73.1, 73.3, 145, 196, 221, 242	3/25/2005	SPC
156	244.15	3/25/2005	SPC
156	244.16	3/25/2005	SPC
156	244.18	3/25/2005	SPC
156	244.19	3/25/2005	SPC
156	247-250	3/25/2005	SPC
156	256, 268	3/25/2005	SPC
156	277, 278	3/25/2005	SPC
156	308.2	3/25/2005	SPC
156	308.4	3/25/2005	SPC
264	510, 239	3/25/2005	SPC
264	259, 261	3/25/2005	SPC
264	294	3/25/2005	SPC
356	244, 246	3/25/2005	SPC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
156	73.1, 73.3	3/25/2005	SPC
156	145, 196	3/25/2005	SPC
156	221, 242	3/25/2005	SPC
156/244.15, 244.16, 244.18, 244.19, 247-250, 256, 268, 277,		3/25/2005	SPC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text and image search on EAST	3/25/2005	SPC
Inventor search on EAST and PALM on Robert Shartle	3/25/2005	SPC

Search Notes (continued)

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SEARCHED

Class	Subclass	Date	Examiner
422	55-58, 31, 61, 72, 102	3/25/2005	SPC
356	534-536	3/25/2005	SPC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
156	278,308.2	3/25/2005	SPC
156	308.4	3/25/2005	SPC
264	510, 239	3/25/2005	SPC
264/259, 261, 294; 356/244, 246, 534-536; 422/55-58, 31, 61, 72, 102		3/25/2005	SPC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR